

Notice of References Cited	Application/Control No. 10/668,634	Applicant(s)/Patent Under Reexamination SPAIN, DAVID STEVENSON	
	Examiner Charles Shedrick	Art Unit 2617	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,249,252	06-2001	Dupray, Dennis J.	342/450
*	B	US-6,236,365	05-2001	LeBlanc et al.	342/457
*	C	US-5,293,642	03-1994	Lo, Wing F.	455/456.2
*	D	US-4,818,998	04-1989	Apsell et al.	342/444
*	E	US-4,908,629	03-1990	Apsell et al.	342/457
*	F	US-6,839,560	01-2005	Bahl et al.	455/456.1
*	G	US-5,390,339	02-1995	Bruckert et al.	455/440
*	H	US-4,891,650	01-1990	Sheffer, Eliezer A.	342/457
*	I	US-5,295,180	03-1994	Vendetti et al.	455/456.2
*	J	US-6,658,258	12-2003	Chen et al.	455/456.1
*	K	US-2004/0057507 A1	03-2004	Rotstein et al.	375/219
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.